

## **Supporting Information**

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## Structure and Charge Control in Metal-Organic Frameworks Based on the Tetrahedral Ligand Tetrakis(4-tetrazolylphenyl)methane

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	1	2	2d
formula	$C_{816}H_{712}Mn_{48}N_{424}O_{64}$	$C_{131}H_{121}Cl_4Cu_{10}N_{69}O_{16}$	$C_{116}H_{64}Cl_{2.8}Cu_{9.4}N_{64}$
FW	20119.2	3695.2	3050.85
<i>T</i> , K	171(2)	165(2)	154(2)
cryst. syst., space group	Cubic, Ia-3d	Tetragonal, I4/mmm	Tetragonal, I4/mmm
Ζ	24	1	1
a, Å	35.451(1)	15.501(1)	16.091(1)
<i>c</i> , Å		29.401(4)	28.187(3)
$V, \text{\AA}^3$	44555(5)	7064(1)	7299(1)
$d_{\rm calc}, {\rm g/cm}^3$	0.750	0.869	0.694
$\mu$ , mm <sup>-1</sup>	0.37	0.82	0.73
<i>F</i> (000)	10288	1876	1528.2
crystal size, mm <sup>3</sup>	$0.52 \times 0.37 \times 0.30$	$0.43 \times 0.25 \times 0.15$	$0.30\times0.10\times0.10$
theta range	4.596 to 35.242	4.636 to 51.587	4.601 to 39.691
index ranges	$-29 \leq h \leq 30$	$-14 \leq h \leq 19$	$-14 \leq h \leq 16$
	$-30 \leq k \leq 30$	$-19 \leq k \leq 17$	$-16 \leq k \leq 16$
	$-27 \le 1 \le 30$	$-30 \leq 1 \leq 36$	$-25 \leq 1 \leq 29$
refl. collected	51888	20293	14360
data / restr. / param.	1293 / 0 / 159	2092 / 0 / 128	1311/0/71
GOF on $F^2$	2.251	1.194	0.935
Larg. peak / hole, e/Å <sup>3</sup>	0.463 and -0.354	0.90 and -0.91	0.65 and -0.31
$\begin{array}{l} R_1  (wR_2),  \%, \\ \left[I > 2 \operatorname{sigma}(I)\right]^b \end{array}$	14.74 (43.36)	7.66 (23.17)	4.00 (10.84)

Table S1. Crystallographic data<sup>*a*</sup> for compounds **1**, **2**, and **2d**.

<sup>a</sup> Obtained with graphite-monochromated Mo-K $\alpha$  ( $\lambda = 0.71073$  Å) radiation. <sup>b</sup> R<sub>1</sub> =  $\Sigma ||F_o| - |F_c|| / \Sigma |F_o|$ ,  $wR_2 = \{ \Sigma [w(F_o^2 - F_c^2)^2] / \Sigma [w(F_o^2)^2] \}^{1/2}$ .



Scheme S1. Synthetic approach for the formation of H<sub>4</sub>TTPM. Conditions and reactants:  $a = Br_2$  (neat, 30 min); b = CuCN/DMF (reflux, 2 days);  $c = NaN_3$  (toluene:MeOH solvent mixture, 7:3 ratio, reflux, 3 days)



Figure S1. Thermogravimetric analysis plot for compound 1.



Figure S2. Thermogravimetric analysis plot for compound **2**.



Figure S3. Powder X-ray diffraction patterns for as-synthesized **2** (red) and simulated from the X-ray crystal structure of **2** (black). Note that the widening of the diffraction peaks and the weak intensity of high-angle diffraction data denotes a small particle size and possible loss of long-range ordering.